TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSII⁻⁵)

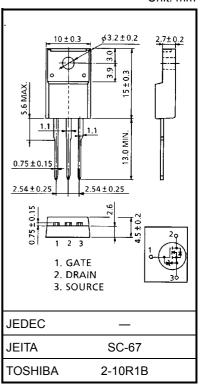
2SK2274

Chopper Regulator, DC–DC Converter and Motor Drive Applications

- Low drain-source ON resistance $: R_{DS} (ON) = 1.5\Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 2.5 \text{ S (typ.)}$
- Low leakage current $: IDSS = 300 \ \mu A \ (max) \ (VDS = 640 \ V)$
- Enhancement-mode : $V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ ID} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

| Characteri | stics | Symbol | Rating | Unit | |
|--|----------------|------------------|---------|------|--|
| Drain-source voltage | | V _{DSS} | 700 | V | |
| Drain-gate voltage (R _{GS} = 20 kΩ) | | V _{DGR} | 700 | V | |
| Gate-source voltage | | V _{GSS} | ±30 | V | |
| Drain current | DC (Note 1) | ۱ _D | 5 | А | |
| | Pulse (Note 1) | I _{DP} | 15 | А | |
| Drain power dissipation (Tc = 25°C) | | PD | 45 | W | |
| Channel temperature | | T _{ch} | 150 | °C | |
| Storage temperature range | | T _{stg} | -55~150 | °C | |



Weight: 1.9 g (typ.)

Thermal Characteristics

| Characteristics | Symbol | Max | Unit |
|--|------------------------|------|--------|
| Thermal resistance, channel to case | R _{th (ch-c)} | 2.77 | °C / W |
| Thermal resistance, channel to ambient | R _{th (ch-a)} | 62.5 | °C / W |

Note 1: Please use devices on condition that the channel temperature is below 150°C.

This transistor is an electrostatic sensitive device. Please handle with caution. Unit: mm

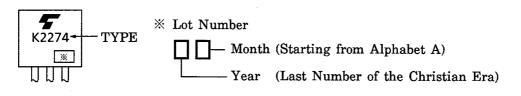
Electrical Characteristics (Ta = 25°C)

| Charac | cteristics | Symbol | Test Condition | Min | Тур. | Max | Unit |
|---|-----------------|----------------------|---|-----|------|------|------|
| Gate leakage cu | ırrent | I _{GSS} | V_{GS} = ±30 V, V_{DS} = 0 V | _ | _ | ±100 | nA |
| Drain cut-off cu | rrent | I _{DSS} | V _{DS} = 640 V, V _{GS} = 0 V | | _ | 300 | μA |
| Drain-source br | eakdown voltage | V (BR) DSS | I _D = 10 mA, V _{GS} = 0 V | 700 | _ | _ | V |
| Gate threshold v | voltage | V _{th} | V _{DS} = 10 V, I _D = 1 mA | 1.5 | _ | 3.5 | V |
| Drain-source O | N resistance | R _{DS (ON)} | V _{GS} = 10 V, I _D = 2 A | | 1.5 | 1.7 | Ω |
| Forward transfe | r admittance | Y _{fs} | V _{DS} = 20 V, I _D = 2 A | 1.0 | 2.5 | _ | S |
| Input capacitance | ce | C _{iss} | | | 610 | _ | |
| Reverse transfe | r capacitance | C _{rss} | V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz | | 60 | _ | pF |
| Output capacitance | | C _{oss} | | | 110 | _ | |
| T Switching timeF | Rise time | tr | $V_{GS} \stackrel{10V}{}_{0V} \int I_{D} = 2A \\ V_{GS} \stackrel{V_{OUT}}{}_{0V} \int R_{L} = 200\Omega$ | _ | 55 | _ | |
| | Turn-on time | t _{on} | | _ | 80 | _ | 20 |
| | Fall time | t _f | | _ | 65 | _ | - ns |
| | Turn-off time | t _{off} | $V_{DD} = 400V$ Duty $\leq 1\%$, t _w = 10 μ s | _ | 240 | _ | |
| Total gate charge (Gate-source plus gate-drain) | | Qg | | _ | 44 | — | |
| Gate-source charge | | Q _{gs} | V _{DD} = 400 V, V _{GS} = 10 V, I _D = 5 A | | 20 | — | nC |
| Gate-drain ("miller") charge | | Q _{gd} | | | 24 | — | |

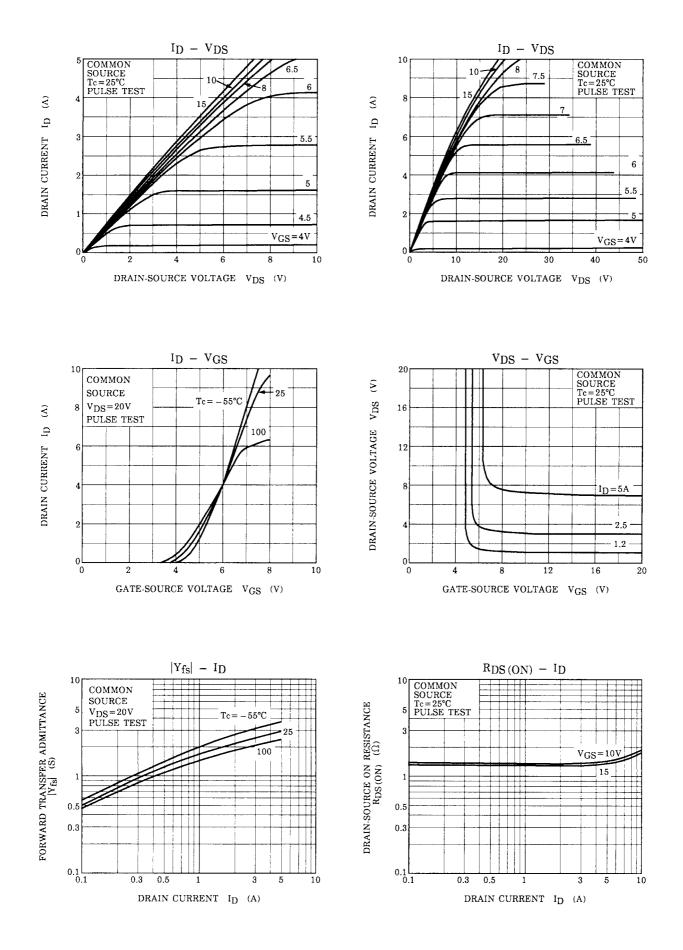
Source–Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics | Symbol | Test Condition | Min | Тур. | Max | Unit |
|--|------------------|--|-----|------|------|------|
| Continuous drain reverse current (Note 1) | I _{DR} | — | _ | _ | 5 | A |
| Pulse drain reverse current (Note 1) | I _{DRP} | — | _ | | 15 | A |
| Forward voltage (diode) | V _{DSF} | I _{DR} = 5 A, V _{GS} = 0 V | _ | _ | -1.9 | V |
| Reverse recovery time | t _{rr} | I _{DR} = 5 A, V _{GS} = 0 V | | 520 | — | ns |
| Reverse recovered charge | Q _{rr} | dI _{DR} / dt = 100 A / µs | _ | 10.4 | _ | μC |

Marking

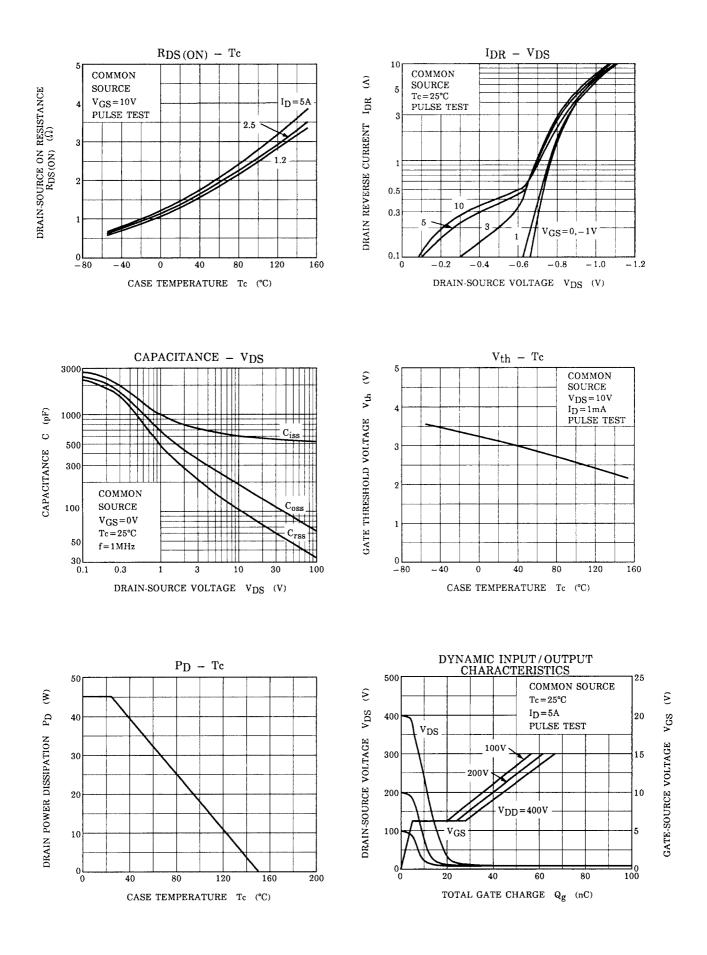


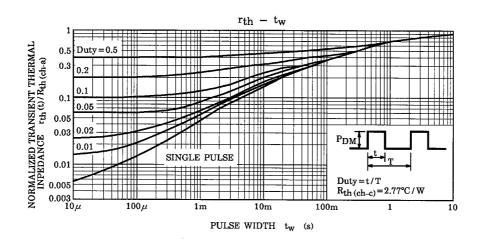
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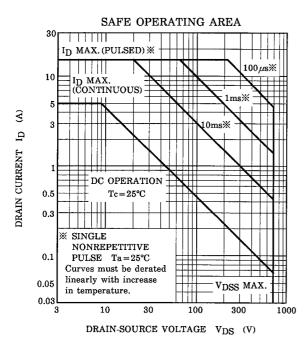


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